



Truesemi

TSP740MR/TSF740MR 400V N-Channel MOSFET

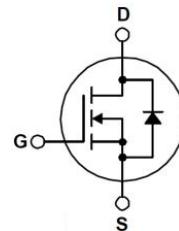
TSP740MR/TSF740MR

General Description

This Power MOSFET is produced using Truesemi's advanced planar stripe DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction based on half bridge topology.

Features

- 10.5A, 400V, $R_{DS(on)typ.} = 0.43\Omega @ V_{GS} = 10V$
- Low gate charge (typical 15.7nC)
- High ruggedness
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



Absolute Maximum Ratings

$T_C = 25^\circ C$ unless otherwise noted

Symbol	Parameter	TSP740MR	TSF740MR	Units
V_{DSS}	Drain-Source Voltage	400		V
I_D	Drain Current - Continuous ($T_C = 25^\circ C$)	10.5	10.5 *	A
	- Continuous ($T_C = 100^\circ C$)	6.6	6.6 *	A
I_{DM}	Drain Current - Pulsed (Note 1)	40	40 *	A
V_{GSS}	Gate-Source Voltage	±25		V
EAS	Single Pulsed Avalanche Energy (Note 2)	360		mJ
I_{AR}	Avalanche Current (Note 1)	11		A
E _{AR}	Repetitive Avalanche Energy (Note 1)	19.36		mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	4.5		V/ns
P_D	Power Dissipation ($T_C = 25^\circ C$)	193.6	39.8	W
	- Derate above $25^\circ C$	1.55	0.32	W/ $^\circ C$
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150		$^\circ C$
T_L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300		$^\circ C$
$V_{ESD(G-S)}$	Gate Source ESD (HBM - C = 100pF, R = 1.5K Ω)	2500		V

* Drain current limited by maximum junction temperature.

Thermal Characteristics

Symbol	Parameter	TSP740MR	TSF740MR	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.65	3.15	$^\circ C/W$
$R_{\theta JS}$	Thermal Resistance, Case-to-Sink Typ.	0.5	--	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	62.5	$^\circ C/W$

Typical Characteristics

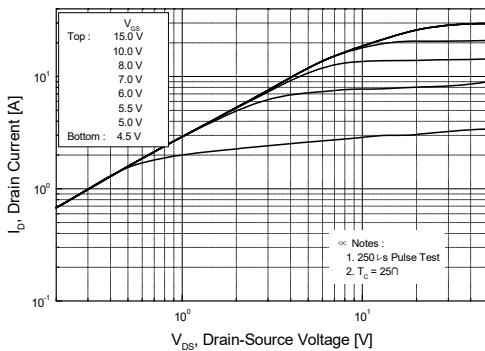


Figure 1. On-Region Characteristics

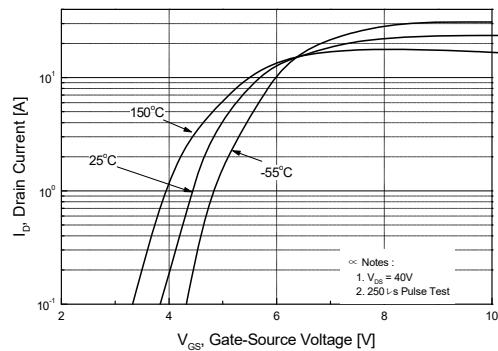


Figure 2. Transfer Characteristics

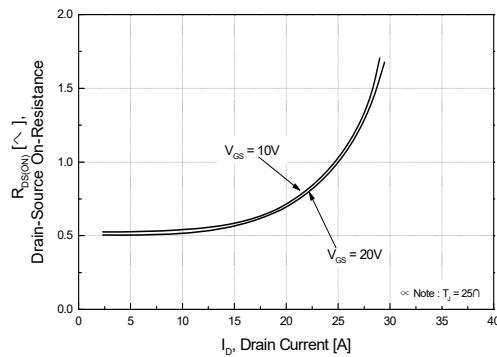


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

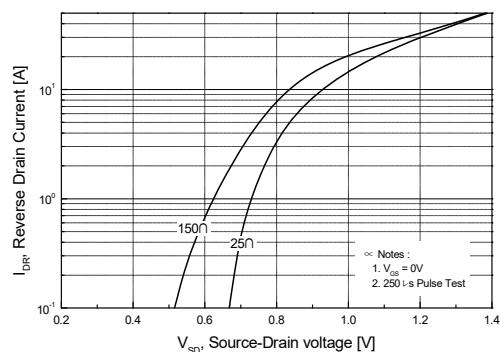


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

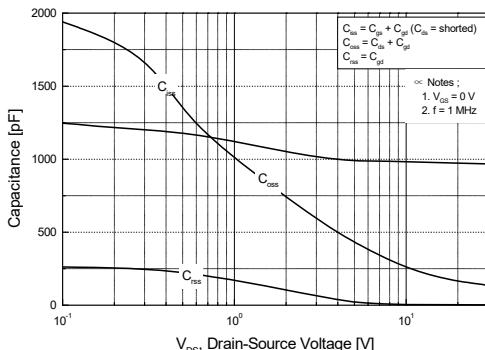


Figure 5. Capacitance Characteristics

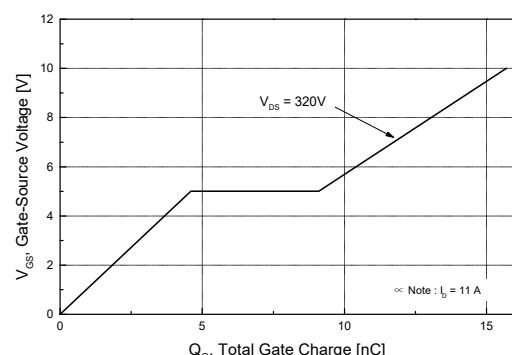
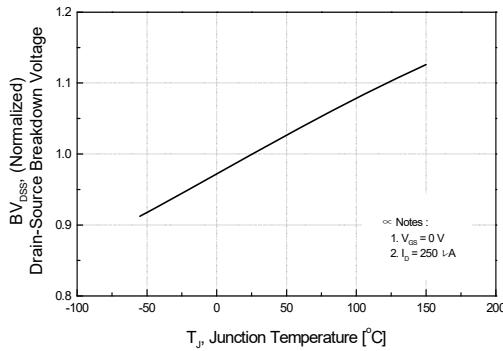
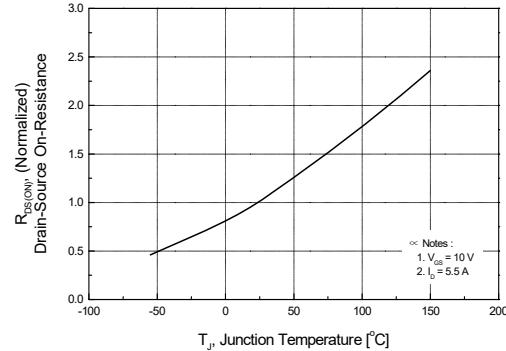
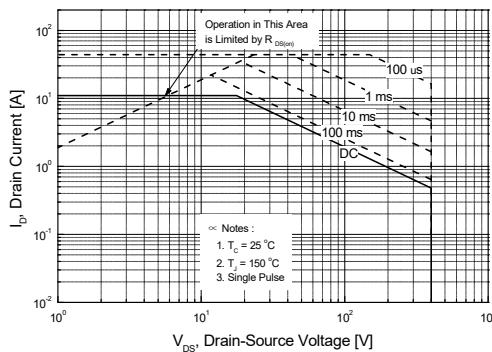
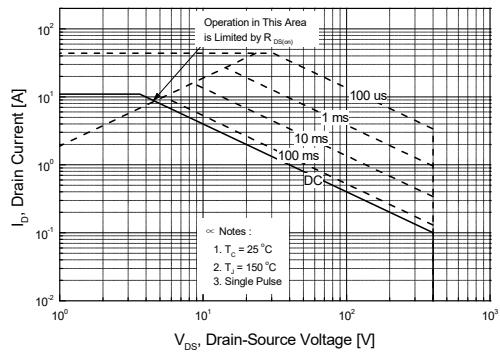
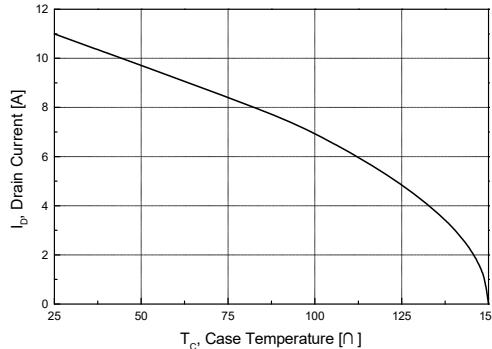
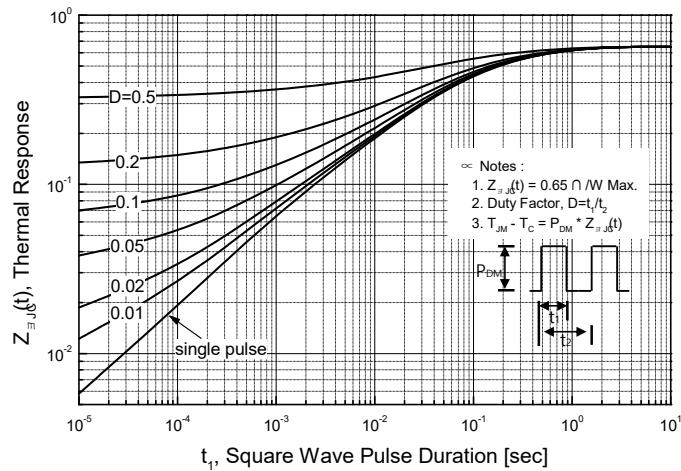
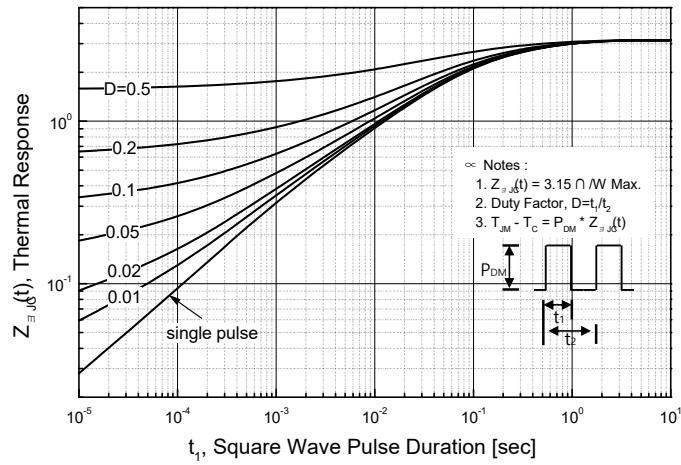
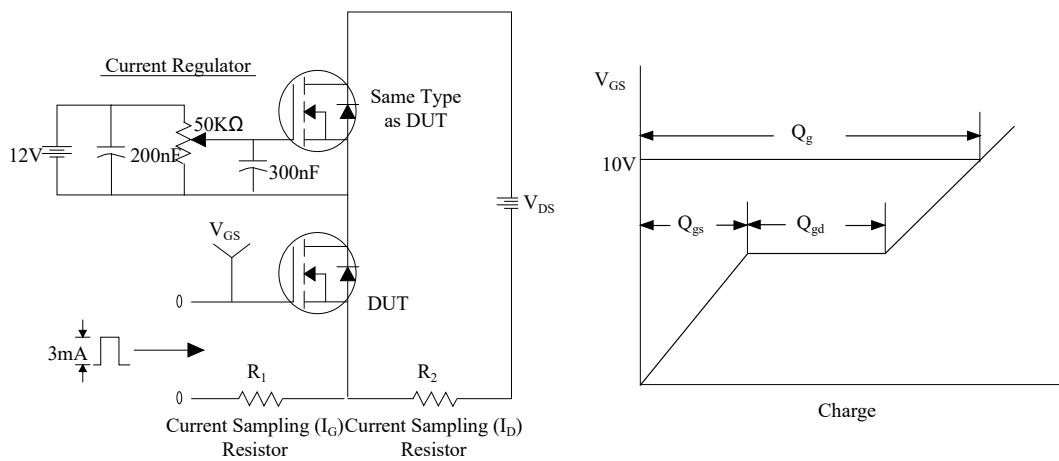


Figure 6. Gate Charge Characteristics

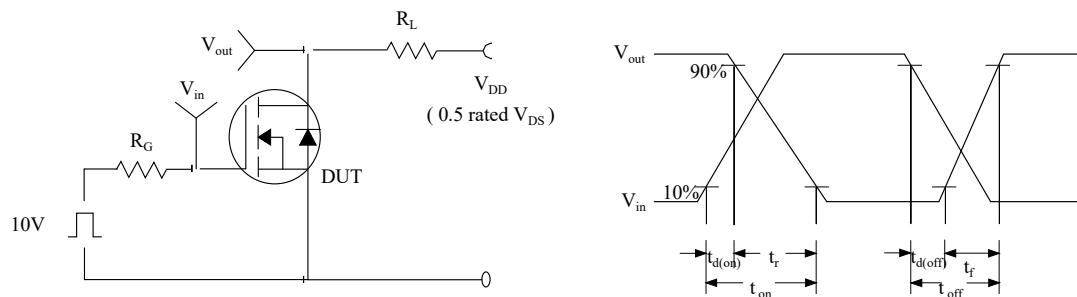
Typical Characteristics (Continued)**Figure 7. Breakdown Voltage Variation vs Temperature****Figure 8. On-Resistance Variation vs Temperature****Figure 9-1. Maximum Safe Operating Area for TSP740MR****Figure 9-2. Maximum Safe Operating Area for TSF740MR****Figure 10. Maximum Drain Current vs Case Temperature**

Typical Characteristics (Continued)**Figure 11-1. Transient Thermal Response Curve for TSP740MR****Figure 11-2. Transient Thermal Response Curve for TSF740MR**

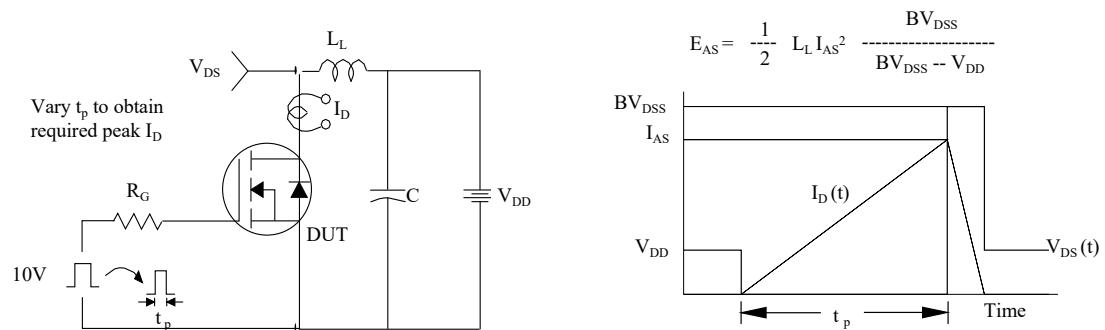
Gate Charge Test Circuit & Waveform



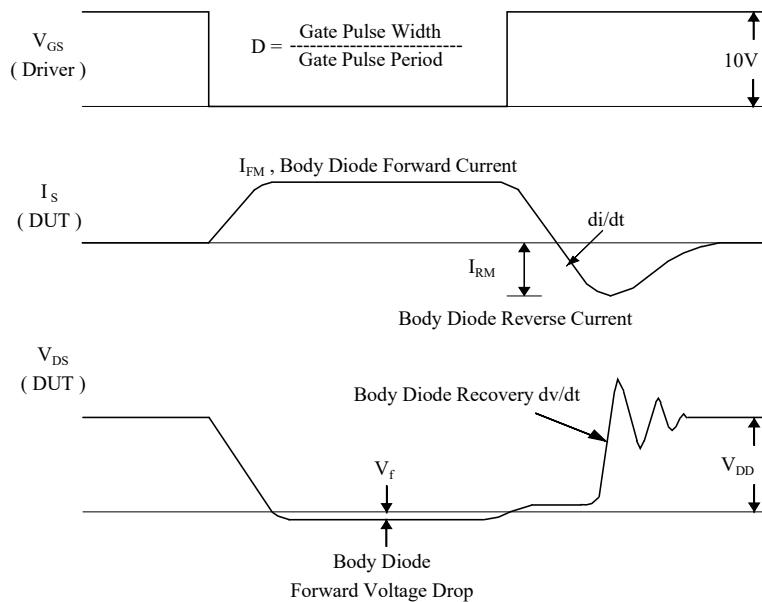
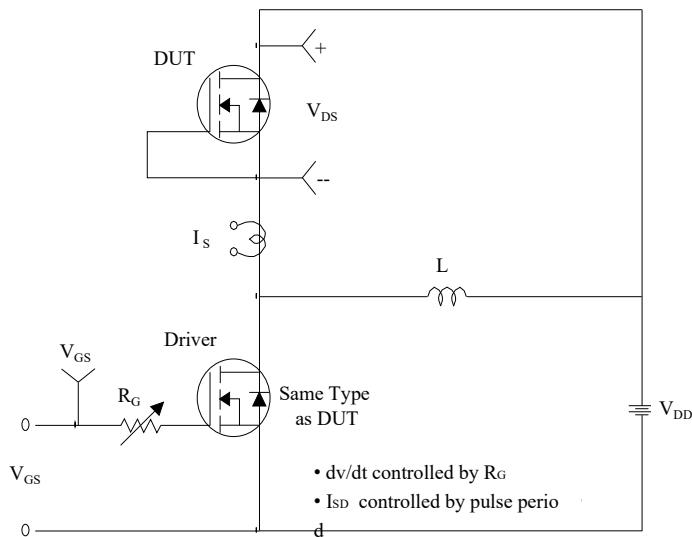
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms



Peak Diode Recovery dv/dt Test Circuit & Waveforms





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[>>Truesemi \(信安\)](#)